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We present low temperature resistivity and magnetotransport measurements conducted on pristine and electron doped SmNiO\textsubscript{3} (SNO). The low temperature transport in both pristine and electron-doped SNO shows a Mott variable range hopping with a substantial decrease in localization length of carriers by one order in the case of doped samples. Un-doped SNO films show a negative magnetoresistance (MR) at all temperatures characterized by spin fluctuations with the evolution of a positive cusp at low temperatures. In striking contrast, upon electron doping of the films via hydrogenation, we observe a crossover to a linear non-saturating positive MR~0.2 \% at 50 K. The results signify the role of localization phenomena in tuning the magnetotransport response in doped nickelates. Ionic doping is therefore a promising approach to tune magnetotransport in correlated perovskites.

I. INTRODUCTION

Rare earth nickelates (RNiO\textsubscript{3}) display a rich phase diagram including a metal-insulator transition and antiferromagnetic transition that are controlled by the radius of the rare earth ion (R\textsuperscript{3+}). The metal-insulator transition temperature decreases with increase in radii of the rare earth ion \textsuperscript{1–3}. The transition to the antiferromagnetic state (T\textsubscript{N}) occurs at the same temperature as metal-insulator transition (T\textsubscript{MI}) for the lighter rare earth (R =Nd, Pr), whereas for heavier elements, T\textsubscript{N} < T\textsubscript{MI} with T\textsubscript{N} progressively decreasing from Sm to Lu. An essential feature of the magnetic transition is that it is first order in nature when T\textsubscript{N} = T\textsubscript{MI} whereas nickelates with T\textsubscript{N} < T\textsubscript{MI} exhibit a second-order magnetic transition.

One of the remarkable features of these nickelate systems is that they can be tuned across a variety of phases like strange metals with non-Fermi liquid behavior, paramagnetic insulator and antiferromagnetic insulator by means of strain, heterostructuring and doping resulting in novel effects like quenching of antiferromagnetic phase in strained NdNiO\textsubscript{3}\textsuperscript{4}, metal-insulator transition in ultrathin films of LaNiO\textsubscript{3}\textsuperscript{5,6}, suppression of paramagnetic insulating phase\textsuperscript{7}, spin density wave order in nickelates\textsuperscript{8,9}, and band gap modulation in SmNiO\textsubscript{3}\textsuperscript{10}. Carrier doping by electrostatic gating or chemical substitution is an active field to modify electronic properties of nickelates\textsuperscript{11–15} at the same time serving as a tool to understand and possibly control the metal insulator transition (MIT) phenomenon in nickelates. Earlier studies regarded nickelates as charge transfer insulators\textsuperscript{16} whereas in recent works, the origin of insulating phase in nickelates has been attributed to charge disproportionation of the Ni site with an accompanying structural change from orthorhombic to monoclinic phase\textsuperscript{17–20}. Electrolytic gating measurements on thin films of NdNiO3 point towards a Mott-type mechanism where the MIT is driven by critical carrier density that is controlled by the gate voltage\textsuperscript{11}. Electrostatic gating and hole doping by Sr have been used to tune T\textsubscript{MI} in NdNiO\textsubscript{3}\textsuperscript{12,21}. Nickelates when substituted with ferromagnetic element like Co have been shown to exhibit spin glass behavior due to competing ferro and anti-ferromagnetic interactions\textsuperscript{22}. Chemical doping by hydrogen incorporation into nickelate lattices has been shown to modify the ground state properties by inducing a colossal change in the resistivity that can be reversed by removing the dopant species from the lattice\textsuperscript{10}. Nickelates have also been proposed to serve as candidate systems for understanding high temperature superconductivity due to the rich physics inherent in d-orbital non-degeneracy\textsuperscript{23–25}. These interesting observations opens up a possibility of realizing new electrical and magnetic ground states for the electron doped nickelates.

Previous experiments on pristine nickelates have shown the low temperature transport to be dominated by hopping mechanism. In case of NdNiO\textsubscript{3}, the low temperature resistivity behavior was modeled as a combination of activation and variable range hopping (VRH)\textsuperscript{26}. SNO thin films have also been shown to exhibit variable range hopping at low temperatures\textsuperscript{27}. These results signify the presence of localized states that dominate the low-temperature phase of nickelates. Unlike conventional semiconductors, nickelates display a non-monotonic behavior in magnetoresistance which has been attributed to its antiferromagnetic nature\textsuperscript{28,29}. Non-monotonic behavior in magnetoresistance has also been seen in other correlated oxide systems of SrTiO\textsubscript{3} quantum wells sandwiched between SmTiO\textsubscript{3} and the results were interpreted in terms of spin scattering of carriers\textsuperscript{30}. Recently the influence of strong localization and disorder on the ground state properties of topological insulator thin films were studied using magnetotransport which showed a reversal in the sign of MR\textsuperscript{31}. 
In this paper, we present a method to tune the magnetotransport properties of perovskite nickelates by electron doping via hydrogenation. Electron occupancy in the Ni orbitals are modified and simultaneously disorder is introduced due to the interstitial dopants. This creates a rich environment to tune magnetic order and we model the results taking into account of spins in localized states.

II. EXPERIMENTS

SmNiO$_3$ (SNO) thin films (100 nm) were prepared by co-sputtering from Sm and Ni targets in Ar/O$_2$ atmosphere onto a single crystal lanthanum aluminate substrate$^{32}$. Metal contacts (Pt/Ti/Au - 100/5/100 nm) were then patterned on the films for four probe electrical transport measurements. Doping of these films were carried out by annealing them at 200$^\circ$ C in forming gas (5% H$_2$ in N$_2$) for 3 hours. During this process Pt electrodes serve as catalyst to dissociate the H$_2$ into atomic hydrogen which then splits into H$^+$ and e$^-$ which are subsequently incorporated into SNO lattice thereby changing the valence state of nickel to Ni$^{2+}$. Dopants are incorporated robustly into the material via the anneal process. We refer to the electron doped SNO as HSNO henceforth in the manuscript. The transport measurements were carried out in Quantum Design Dynacool PPMS system in a temperature range of 2.2 K to 300 K and magnetic field up to 9 T with a small signal AC excitation of 10 nA. The measurements of HSNO could be made only down to about 40 K as the resistivity of these films increased beyond the measurable range of the PPMS system in a four wire configuration. Conducting Atomic Force Microscopy (CAFM) measurements were performed at room temperature using an Asylum MFF3D standalone AFM and Asylum ASYIELEC-01 conductive tips (Si coated with Ti/Ir). The bias (1 V$_{DC}$) was applied to sample with a 1 M$\Omega$ resistor in series while the AFM tip is grounded. The resistor serves to limit the maximum current so as to avoid any damage to the metal coating on the tip. The current flowing from the sample to the tip is amplified using current amplifiers (dual gain ORCA) with a sensitivity of 1 V/nA and 1 V/µA. The scan area was chosen to be 5×5 µm$^2$ with a scan rate of 1 Hz. Raman spectra were recorded using a confocal microscope system with an excitation laser of 532 nm. The laser spot size is ∼1 µm$^2$ enabling us to scan across SNO/HSNO boundary. Raman modes were also calculated from first principles and the details are presented in the Supplementary section.

III. RESULTS AND DISCUSSION

The resistivity of pristine SNO and HSNO films display an insulating behavior over the entire temperature range of our measurements. Rare earth nickelates are found to exhibit variable range hopping at low temperatures$^{36,33}$ where it is energetically favorable for an electron to hop to a site that is closer in energy than the nearest neighbor leading to VRH and is given by

$$\rho(T) = \rho_1 \exp \left( \frac{T_0}{T} \right)^p$$

where $\rho_1$ is the prefactor, $T_0$ is the characteristic temperature and $p$ is the exponent dependent on the conduction mechanism. The type of VRH conduction is dependent on the details of the density of states (DOS) around Fermi energy ($E_F$). It was shown by Mott$^{38}$ that for a constant DOS, $p = 1/(D+1)$ where $D$ is the dimensionality of the system. In three dimensions, $p = 1/4$ and $T_0$ is given by$^{39,40}$

$$T_0 \equiv T_{Mott} = \frac{18}{k_B N(E_F) \xi^3}$$

where $N(E_F)$ is the DOS near $E_F$ and $\xi$ is the localization length. When Coulomb interaction between charge carriers is taken into account, a gap appears in the DOS near $E_F$ and one can show that $p = 1/2$. This mechanism is known as Efros-Shklovskii (ES) VRH$^{11}$ where $T_0 = \frac{2.8 \epsilon^2}{4 \pi e k_B \xi^3}$, $\epsilon$ being the dielectric permittivity.

In our experiments, pristine SNO film display a Mott VRH mechanism at low temperature ($T < 20$ K) as evident from the linearity of $\ln(\rho)$ vs $T^{-0.25}$ (Fig. 1a). The

![Figure 1: a) Plot of $\ln(\rho)$ vs $T^{-1/4}$ for SNO and HSNO. Black lines are linear fit indicating Mott VRH. b) Comparison of $T_M$ vs $\rho$ for SNO and HSNO films with other oxide systems. SNO, HSNO (this work), Sm$_{0.5}$Ni$_{0.5}$O$_3$ (SNOO)$^{31}$, La$_3$Ni$_2$O$_6$$^{34}$, CaCu$_2$Ti$_4$O$_{12}$ (CCTO)$^{33}$, Nd$_2$O$_3$$^{36}$, Na$_2$IrO$_3$$^{37}$. c,d) CAFM images for SNO and HSNO over a region of 5×5 µm$^2$. CAFM of doped sample appears dark due to large suppression of electronic conductivity.](image-url)
HSNO film shows remarkably strong localization behavior with Mott VRH over a larger temperature range from 300 K to 40 K. The linear fits yield $T_{Mott} = 2.6 \times 10^4$ K for SNO and using Eqn. 2, we find $\xi \sim 37$ nm taking $N(E_F) = 1.5 \times 10^{18} \text{eV}^{-1}\text{cm}^{-3}$. For HSNO, the magnitude of $T_{Mott}$ ($T_{Mott} = 4.7 \times 10^6$ K) is about three orders of magnitude higher than that of SNO with a relatively small $\xi \sim 3$ nm. Here we have assumed $N(E_F)$ to remain approximately the same even after doping. The reason is that unlike other oxide semiconductors$^{42,43}$ where hydrogen doping introduces states near conduction band, in SNO, hydrogen doping leads to large change in bandgap of the material$^{10}$. To check the consistency of the fits for the Mott VRH in SNO and HSNO, we have calculated the hopping distance $R_h = (\frac{92}{8\pi G\sqrt{N(E_F)}})^{1/4}$ and the average hopping energy $W_h = \frac{2}{3} R^{2} \pi N(E_F)$. We find that for both pristine and doped SNO films, the conditions $\frac{R_h}{\xi} > 1$ and $\frac{W_h}{\xi^2} > 1$ are satisfied for the validity of Mott VRH process. A comparison of $T_{Mott}$ for SNO and HSNO with various systems of correlated oxides is shown in Fig. 1b. We find good agreement for SNO with other nickelates$^{33}$ and HSNO falls into the category of oxides showing a stronger carrier localization with higher $T_{Mott}$. These correlated oxides also show a trend with increase in $T_{Mott}$ as $\rho$ of the film increases signifying that highly resistive films display a stronger localization behavior. We have also carried out transport at nanoscale using CAFM which measures the current spatially across the sample. The CAFM images of both pristine and electron doped SNO grown on Si/SiO$_2$ substrate are shown in Fig. 1c,d. The current levels in SNO is about four orders of magnitude larger than that of HSNO. The current profile of HSNO is homogeneous indicating the spatial homogeneity of doping.

To further understand the effects of electron doping on the phonon modes in nickelates, we have performed spatial Raman mapping of SNO-HSNO region which is shown in Fig. 2a. The optical image of the sample near the platinum electrode is shown in the inset of Fig. 2a where we see a clear optical contrast between SNO and HSNO regions and line (length 30 $\mu$m) over which the Raman scan was performed is shown as red. As shown in the Raman scan, a clear distinction is seen in the Raman modes of SNO and HSNO region. The mode with larger intensity at $\sim 450$ cm$^{-1}$ corresponding to $A_g$ mode seen in SNO films is clearly absent in HSNO where a new mode emerges at 617 cm$^{-1}$. The emergence of a new mode in HSNO is possibly due to breaking of some underlying symmetry in the nickelate lattice. The uniformity of the Raman scan is also indicative of spatial homogeneity of SNO and HSNO regions. Perovskite nickelates in their insulating state exhibit monoclinic distortion ($P2_1/n$ space group) with 24 Raman active modes which are represented as$^{44}$

$$\Gamma_{\text{Raman}} = 12A_g + 12B_g$$

(3)

Using DFT calculations (details in Supplementary section) we have determined all the 24 modes for pristine SNO and a comparison with experimentally observed modes is shown in Table. I. We get a good agreement between theory and experiment with rms error $\sim 5$ cm$^{-1}$. Our calculations show that the mode at 444.9 cm$^{-1}$ is mainly contributed from the movements of O atoms in the 8d Wyckoff positions. In Fig. 2b, we show the Raman spectrum in pristine SNO which is in good agreement with that of reported in Ref. 44. The dotted lines correspond to modes predicted by DFT.

We then investigate the mechanism of strong carrier localization in doped nickelates by measuring the magnetoresistance ($MR = [(\rho(H) - \rho(0))/\rho(0)]$) in both SNO and HSNO films at various temperatures. In SNO, MR which is positive at low fields ($H \lesssim 3$ T) shows a crossover to negative magnetoresistance behavior at higher fields (Fig. 3a). The positive MR is suppressed at higher temperatures ($T \gtrsim 10$ K). The field ($H_m$) at which cross over in MR occurs exhibits a non-monotonic response as a function of temperature with a minima at 5 K (Fig. 3d). The positive MR seen at low fields is about 0.7% at 2.24 K and decreases with increase in temperature. The magnitude of negative MR (taken at 9 T)
reaches its maximum value of \(\sim 2.5\%\) at 5 K and displays a similar trend to that of \(H_m\) (Fig. 3d). For \(T > 5\text{K}\), the negative MR decreases in magnitude and is eventually suppressed by \(\sim 10\text{K}\). A remarkably different behavior is seen in HSNO films where the MR is positive over the entire field range and its value decreases as temperature is increased (Fig. 3b). The MR for pristine and electron doped film at \(T = 50\text{K}\) is shown in Fig. 3c for comparison. A clear sign reversal from negative to positive magnetoresistance is seen with electron doping. In systems of correlated iridates, sign reversal in MR has been observed as a function of temperature.\(^{45}\). We emphasize that the sign reversal in MR is caused by the incorporation of dopants and rule out any effects of temperature (details in supplementary section).

In order to understand the connection between the magnetoresistance behavior and strong carrier localization, we look at the different mechanisms that contribute to magnetoresistance in correlated oxides. Negative MR can arise from various mechanisms such as weak localization, hopping conduction and magnetic scattering while mechanisms like wave function shrinkage and strong spin orbit scattering lead to positive MR. After a systematic analysis detailed in the Supplementary Material) of the data using various models for MR, the MR behavior in pristine SNO films can be modeled by two competing mechanisms resulting from correlation among spins in localized states. Frydman et al.\(^{46,47}\) had proposed that in samples exhibiting variable range hopping conduction, exchange correlation among spins in different hopping sites can give rise to positive MR (negative magnetoconductance) that tends to saturate at a characteristic field called spin alignment fields. According to this model, the magnetoconductance (MC) is given as

\[
\frac{\Delta \sigma}{\sigma} = -A_c \left( \frac{H^2}{H^2 + H_c^2} \right)
\]

where \(A_c\) is the saturation value, \(H_c = a \frac{k_B T}{\mu_B} \left( \frac{T}{\mu_B} \right)^{0.25}\) is the spin alignment field, \(a\) is a constant of the order unity and \(\mu_B\) is the Bohr magneton. The negative MR at larger fields can be modeled by hopping conduction through the Zeeman effect.\(^{48,49}\). According to this model, the applied field shifts the Fermi level \(E_F\) by the Zeeman energy \(g \mu_B H\) and causes splitting of the spin-up and spin-down subbands and redistributes carriers among the localized states. This leads to delocalization of the carriers thereby leading to decrease in resistance. The MC according to this model is given as

Figure 3: a) Magnetoresistance (in %) vs \(H\) for SNO film at various temperatures. b) Magnetoresistance (in %) vs \(H\) for HSNO film at various temperatures. c) Comparison of magnetoresistance (in %) vs \(H\) for SNO and HSNO film at \(T = 50\text{K}\). d) Magnetoresistance (in %) (left y-axis) vs \(T\) at \(H = 9\text{T}\) for SNO film. Crossover field \(H_m\) (right y-axis) vs \(T\) for SNO film.

Figure 4: a) Magnetoconductance vs \(H\) for SNO film at various temperatures. Solid black lines are fits according to Eqn. 5. b) Temperature dependence of fit parameter \(H_c\) (black squares). Red squares indicate theoretical predictions for \(H_c\). c) Magnetoresistance vs \(H\) for HSNO film at various temperatures. Solid black lines are guide to eye. d) Illustration of mechanisms leading to magnetoresistance in SNO (top panel) and HSNO (bottom panel) film.
\[ \frac{\Delta \sigma}{\sigma} = c \left( \frac{g \mu_B H}{E_c - E_F} \right)^2 \left( \frac{T_{Mott}}{T} \right)^{0.5} \]

(5)

where \( g \) is the Landé g-factor, \( E_c \) is the mobility edge and \( c \) is a constant of the order of unity. Combining the above two models, MC in SNO is expressed as

\[ \frac{\Delta \sigma}{\sigma} = -A_c \frac{H^2}{H^2 + H_c^2} + c \left( \frac{g \mu_B H}{E_c - E_F} \right)^2 \left( \frac{T_{Mott}}{T} \right)^{0.5} \]

(6)

Fig. 4a shows the fits for MC for SNO at different temperatures. Here we take \((E_c - E_F) \sim 0.1 \text{ eV}\), typical bandgap in SNO\textsuperscript{50} and the error bars obtained for the fit parameters are within 5%. The model is valid for \((\frac{E_c}{g \mu_B H})^{0.25} \gg 1\) which is true in our case. Fig. 4b shows \(H_c\) obtained from the fit agree well with the theoretical prediction for \(T < 5 \text{ K}\). We also observe a reasonable agreement of the fit parameter \(c\) with the model which predicts \(c \sim 1\). Fig. 4d (top panel) shows a simplified schematic representation of the magnetotransport in pristine SNO samples at low temperatures which can be understood from a framework of interacting spins localized at different sites\textsuperscript{28–30,51}. Assuming charge disproportionation, the nickelate lattice can be modeled for \(S = 1\) sites antiferromagnetically coupled via \(S = 0\) sites\textsuperscript{20}. Though it is well known that rare earth nickelates exhibit antiferromagnetic order at low temperatures, the precise magnetic structure is complex with proposals of collinear and non-collinear magnetic structures from neutron\textsuperscript{32} and soft x-ray scattering studies\textsuperscript{18} and canted antiferromagnetic state from magnetic susceptibility measurements\textsuperscript{53}. Our measurements at low temperatures (\(T \lesssim 5 \text{ K}\)) yield a positive cusp in the MR signifying the presence of interacting spins that are frozen as seen in systems exhibiting spin glass phase\textsuperscript{54,55}. An application of finite field (\(\sim 3.5 \text{ T}\)) destroys the frozen spin state leading to enhancement in spin scattering resulting in negative MR. At such large fields, the spin are polarized enhancing spin fluctuations and hopping rate of carriers resulting in a decrease in resistance with increase in field. At higher temperatures (\(T > 10 \text{ K}\)), larger thermal energy suppresses the positive cusp, resulting only in negative MR that is quadratic in field. Signatures of such a low temperature spin glass like state have been seen in MR and magnetization measurements in other correlated oxides such as iridates\textsuperscript{34}. The field scale of \(\sim 3.5 \text{ T}\) obtained in our experiments is consistent with the hopping energy in VRH regime which is \(\sim 0.5 \text{ meV}\), thus signifying the role of spin correlations that govern the low temperature transport.

The electron-doped sample shows a remarkably distinct signature in magnetotransport with a linear positive magnetoresistance as against pristine films that exhibit negative magnetoresistance (Fig. 4c). Tuning the MR in oxides can be achieved by introduction of dopants or defects. Incorporation of Mn dopants in ZnO changes the intrinsic positive MR (due to wavefunction squeezing) to a giant negative MR arising from spin scattering caused Mn moments\textsuperscript{56}. Ferromagnetism is seen in hydrogen doped ZnO single crystals investigated by magnetotransport\textsuperscript{57}. Non-monotonous magnetoresistance observed in proton implanted Li-doped ZnO wires has been attributed to enhancement of spin polarization due to doping\textsuperscript{68}. Positive magnetoresistance is commonly observed in systems in strongly localized regime with VRH conduction. In such systems, the wavelength of the localized charge carrier shrinks under the application of a magnetic field thereby leading to a positive MR\textsuperscript{41,59}. Such models predict an exponential dependence of MR on the magnetic field. But we do not see such a behavior in our thin films. In experiments on strongly correlated oxides, linear positive MR has also been seen in SrTiO\textsubscript{3} crystals and was attributed to the presence of point defects\textsuperscript{60}. Non-saturating linear MR has also been observed in high mobility semiconductors due to the fluctuations in the mobility of the carriers\textsuperscript{61,62} and semiconductors in strongly localized regime\textsuperscript{63}. However, to qualitatively understand the mechanism in HSNO, we need to look into details of the doping in SNO films. When SNO is annealed in the hydrogen environment, the hydrogen splits into a proton and an electron at the platinum electrode-SNO interface. The electron goes into \(e_g\) orbital of transition metal changing its valence state to Ni\textsuperscript{2+}. From Hund’s rule, the two electrons in \(e_g\) orbital are likely to have same spin resulting in a high spin state (\(S = 1\)) which is a strongly correlated state (shown in the bottom panel of Fig. 4d). In such a case, one can expect a large fraction of Ni\textsuperscript{2+} leading to strong correlation among localized sites along with significant disorder from the protons in the lattice. The linear positive MR in the electron-doped nickelates might therefore result from a combination of disorder, localization and strong correlations. Such a scenario is seen in systems of organic semiconductor V(TCNE)\textsubscript{2} exhibiting localization and magnetic order. In such systems, it has been shown that exchange interactions between spins of V\textsuperscript{2+} and upper \(\pi^*\) subband of TCNE lead to linear MR\textsuperscript{64,65}. Thus electron-doped nickelates presents itself as a system with tunable magnetotransport mediated by ionic doping and could be of potential interest in the growing field of magneto-ionic devices\textsuperscript{66}.

To summarize, we have shown that it is possible to tune the sign of magnetoresistance in perovskite nickelates via electron doping. Charge localization through orbital occupancy control is therefore an effective route to also modulate magnetotransport in these materials. Further experimental probes like resonant x-ray scattering and neutron diffraction would be valuable to reveal the underlying magnetic structure in electron-doped nickelates.
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